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THERMOLUM INESCIENCE



C_H_A_P_T_E_R IV THERMOLUMINESCENCE

4.1 : INTRODUCTION :

Thermoluminescence is a phenomenon mostly created in artificially prepared phosphors. This property depends on nature of host material, nature of impurity in the host material, the process / condition of doping the impurity and irradiation source on the phosphors.

.TL study can be done with the help of TL glow curve. (Which includes rate of heating the sample). From the glow curve, amount of energy stored by imperfect crystals can be determined which is known as trap depth or activation energy (E) frequency factor (S), and nature of kinetics. The theoretical aspects and their details are included in this chapter.

The object of the present investigation is to analyse the observed glow curves for the samples containing varying percentage of Sm : Nd and Dy : Tb and to determine activation energy and the escape frequency factor. The nature and origin of traps responsible in TL process and their size have been investigated An attempt has been made to determine the type of kinetics involved in thermoluminescence process.

4.2 : THEORETICAL ASPECTS :

4.2.1 : Theory of thermoluminescence :

By studing glow curve Randall and Wilkins (1) gave theoretical aspect. According to them, the impurity and lattice defect which give rise to localised energy levels in the forbidden region constitute the electron traps, hole traps and metastable state. The electrons in metastable states are raised thermally to an excited state from which they return to the ground state with emission of radiation. Randall, Wilkins assumed this to be monomoleculer kinetics or first order kinetics and come to a that conclusion, the decay of such phosphors is exponontial. For this case they neglected the retraping of electrons in the empty traps

Garlick and Gibson (2) have put forth a theory developed by taking in account of equal probabilities for the retraping and recombination of released electron which is known as bimolecular kinetics or second order kinetics (a straight line graph obtained by plotting $(\mathbf{T})^{\frac{1}{2}}$ against time). Electrons in the traps have a Maxwellian distribution of thermal energies (1). Ther<u>e</u> fore, the probability (P) of escape of electron persecond from a trap of depth E (actication energy) is of the form (Arrhenious factor)

$$P = S e^{-E/KT}$$

Where K is Bolizmann constant and T is temperature in OK. S has a unit (Sec)⁻¹ and is hence called the frequency factor. The factor S is a constant but some times it is found to be dependent on the initial concentration of trapped electrons (3) in a given type of traps.

4.2.2 : First order kinetics : Randall and Wilkins Theory :

Randall and Wilkins (1) provided a simple theory for TL glow peak. They assumed that the electrons released on heating are not retrapped but all of these go to the recombination (luminescence) centres resulting in thermoluminescence. There_fore TL intensity proportional to the rate of release of electrons from the trap.

$$I_{\infty} \frac{dn}{dt} = -cpn.$$

= - cns / exp.(- E/KT)

Where n is the number of trapped electrons and c is a constant fearranging,

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$$\frac{dn}{n} = -cse \qquad \frac{dt}{dT} dT.$$
$$= -cse \qquad \frac{e/kT}{\beta} e \qquad .dT$$

Where $\beta = dT/dt$ is heating rate (${}^{O}K / Sec$)

on intergrating both sides and substituting equation (4.2) for the TL intensity.

$$I = n_0' c s e exp \int_0^T - \frac{s}{\beta} e dT^1 ---(4.3)$$

 n_0 is the initial number of trapped electrons, At a fixed temperature T. cse^{- F/KT} is a constant and is taken as λ , Equation (2) can thus be written as.

 $\frac{dn}{n} = -\lambda t$

which on integration gives,

$$= \frac{-7}{n} t$$

$$n = n_0 e$$

$$= \frac{-----}{4.4}$$
equation (4.2) and (4.4.)
$$I = I_0 e^{7/t} (I_0 = \frac{7}{n_0}) ---- (4.5)$$

Thus at a fixed temperature T, TL intensity decays exponentially and TL process is said to be following first order kinetics.

--- (4.2)

4.2.3 : SECOND ORDER OR GARLICK AND GIBSON'S THEORY :-

Garlick and Gibson considered the case, where a free electron has equal probability for go in to recombination centres or returning to the same trap (retrapping). If N is the total number of traps of which n are occupied at a time t, the probability that a released electron will go to the recombination centre is $\frac{n}{(N-n) + n} = \frac{n}{N}$

Therefore
$$I = c \frac{dn}{dt} \frac{n}{N}$$

- E/KT
= - c s e . $\frac{n}{N}$ ------ (4.6)

By integrating eq. (4.6) and rearranging equation for $\uparrow_{\mathbf{L}}$, intensity is obtained as

$$I = \frac{no^{2} c s^{1} e^{-E/KT}}{(1 + s^{1} \frac{n\rho}{\beta} \int_{0}^{T} exp(-E/KT^{1}) dT^{1})^{2} - - - - (4.7)}$$

Where $S^1 = \frac{S}{N}$ is called pre-exponential constant and has the unit (cm³ see⁻¹).

At a fixed temperature T, equation for TL itensity can be derived as

$$I = \frac{I_0}{(1 + \lambda^{1} n_0^{t})^2}$$

Where $\lambda^1 = c s^{1} e^{-E/KT}$ ----- (4.8)

A straight line graph obtained by plotting $(1)^{-\frac{1}{2}}$ against time provides a test for the applicability of second order kinetics in the TL process.

4.2.4 : GENERAL ORDER KINETICS :

In many cases, a process follows neither the first order kinetics nor the second order kinetics. May and Partridge (41) gave a following equation which is applicable to a process following any non first order of kinetics.

$$I = c \frac{dn}{dt}$$

= - c s' n^L exp. (- E/KT) ----- (9)

Where L is order of kinetics and can have any value not necessarily an integer solution of

$$I = S^{T} n_{0}^{L} c \exp(-E/KT) \frac{(L-1) s^{t} (n_{0}^{L})^{L-1}}{B}$$

$$\int_{0}^{T} \left[\exp(-E/KT^{t}) dT^{t} + 1 \right] = -(-4.1D)$$

 $S^{4} n_{0}^{1-1}$ has the unit (sec)⁻¹ and in this sense, it is similar to frequency factor S of the first order case. Thus equation (4.10) can be written as

$$I = cS n_{b} exp (-E/KT) \frac{(L-1)s}{\beta} \int_{0}^{T} \left[exp (-E/KT) \frac{dT^{*}}{+1} \right]$$

Eqⁿ (4.11) is not valied for L = 1 but when L^{--1} , it reduces to first order equation (4.3) and for L = 2 It reduces to second order equation (4.7)

TL intensity equation at a fixed temperature T can be derived as under,

From eqn (4.9) $\frac{dn}{nL} = -S'e$ dt = $-P'dt, \left[(P = S'e) \right]$

Which on integration gives

$$n = (a + bt)$$
 ----- (4.12)

Where $a=(n_0)^{L-1}$ and $b = -P^{+} = -P^{-}(L-1)$

Substituting the values of n in (4.9) We get

$$I = -cp' (a + bt) \frac{1}{L-1}$$

or
$$\frac{L-1}{IL} = (-cp') \frac{1}{L-1} (a + bt) ---- (4.13)$$

= A + Bt
Where A = a (-cp') \frac{1}{L-1} and B = (-cp) \frac{1}{L-1} b

Thus, if the TL process is following a general order kinetics, decay of TL intensity with time is governed by equation (4.13) such that plot of $(1)^{\frac{1}{L-1}}$ Vs time would give a straight line.

4.3 : Methods for determing the 'trap depth ' :-

There exist several methods for determing the trap depth from the glow curves and these have been reviewed by Narlikar & Shalgaonkar (3). Using these methods, the trap depth E is estimated either from the peak temperature T_m or from the shape of the glow curve. These methods can be classified into two main types. i)Methods sensitive to the recombination kinetics and i Methods independent of the recombination kinetics.

A) Methods sensitive to the recombination kinetics

1) Randall and Wilkin's method :

Randall and Wilkin's (1) method is based on equation 4.5 which assumes monomolecular kinetics and no retrapping. In this method, Tm corresponds to a temperature a little below that at which the frequency of an electron escaping the trap is one per second, i.e.

S. exp.
$$(-E/KT_m)$$
 $(1 + f(S, P) = 1$ (4.14)

The function f $(s,\beta) \leq \langle 1$ and this gives the trap depth E. The equation for E is

$$E = T_m (1+F(S.\beta)) K \log S \dots (4.15)$$

Where F (S,B) is another function of S and B. When B lies between 0.5 and 2.5 K sec⁻¹ and S equals the value 2.9 X 10^9 sec⁻¹ the above equation reduces to

$$E = 25 \text{ K T}_{m}$$
(4.16)

2) Method due to Urbach :

Although the method due to Randall and Wilkins is earliest published method for determination of trap depth, Urbach (4) from equation 4.5 independently derived an expression for activation energy E by taking $S = 10^9 \text{ sec}^{-1}$. The equation is

$$E = \frac{T_{m}}{500}$$
 (4.17)

3) Method due to Curie :

Following Randall and Wilkins, Curie (5) has given the formula for evaluation of trap depth as

$$E = \frac{T_{m} ({}^{O}k) - T_{0} (\beta/s)}{K (.\beta/s)} \dots (4.18)$$

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Where the functions T_0 and K may be obtained graphically for various sets of (B/S) with 1% accuracy (6,7,8).

It is worth noting that, there exists several other methods to determine which do not require the knowledge of S and hence equation which is obtained by differentiating equation 4.5 with respect to T and equating to zero may be useful (3, 6, 9) i.e.

$$\frac{E}{2} = \frac{S}{\beta} \exp((-E/kT_{m})) \qquad(4.19)$$

4) Method due to Booth and Sohum :

Booth and Sohum (10,11) independently used two heating rates β_1 and β_2 and measured the corresponding values of T_{m_1} and T_{m_2} of the glow maximum. Solving the equation 4.14 for two different heating rates, they found,

$$E = \frac{kT_{m1}}{T_{m_1} - T_{m_2}} \log \frac{B_1 T_{m_2}^2}{B_2 T_{m1}^2} \dots (4.20)$$

The value of S is given by (12)

$$\log \frac{SK}{E} = \frac{\frac{T_{m_2}^2 \log \frac{T_{m_2}^2}{\beta_2} - T_{m_1} \frac{T_{m_1}^2}{\beta_1}}{\frac{T_{m_1}^2 - T_{m_2}}{T_{m_1} - T_{m_2}}} \dots (4.21)$$

If T_m can be measured within an accuracy of $1^{\circ}K$, the method is found to yield E within an error of 5%, Schon (13) has modified the equation 4.15 by replacing T_m^2 by $T_m^{3.5}$ which has resulted in a some what improved accuracy.

5) Isothermal decay method :

In this method, after excitation, the sample is quickly heated to a specific temperature and at this temperature the luminescence decay is measured. The method being isothermal has the advantage that such difficulties, as arising from overlapping of peaks and change in quantum efficiency or the emission spectra occuring under the non isothermal conditions are avoided. The decay curve obtained can be analysed into sum of sharply defined linear region and it has been shown that for the first order kinetics.

I (T) = n_0 S exp. (-E/KT). exp. (S.t.exp. (-E/kT) ...(4.22) Where t is the time. Taking logarithms of equation 4.17, we have

log I (T) = - St exp. (-E/KT). - E/KT + log n_o S ...(4.23) Thus the slope m of the log I (T) versus t curve is given by

$$m_1 = S. \exp(-E/KT)$$
(4.24)

Taking the slopes m_1 and m_2 at two temperatures T_1 and T_2 one can write, m_1

$$\log \frac{1}{m_2} = \frac{(E)}{(K)} (\frac{1}{T_1} - \frac{1}{T_2}) \dots (4.25)$$

Which can be used to determine the activation energy E. The escape frequency factors may be found by the substitution of (4.25) in equation (4.24).

6) Method due to Grossweiner :

Using the equation 4.4 for the first order kinetics, Grossweiner (15) has shown that E in terms of T_m and T_1 is given by

$$E = \frac{\frac{1.51 \times T_m T_1}{(T_m - T_1)}}{(4.26)}$$

Where T_1 is the temperature at which the low termperature side of the glow peak attains one half of the maximum intensity. According to Grossweiner this equation is accurate within \pm 5% provided

that
$$\frac{S}{B^2}$$
 > 10⁷ $_{K}^{o}$ -1 and $\frac{E}{kT_{m}}$ > 20

However Dussel and Bube (16) and Chen (9) have shown that the equation 4,26 yields values which are about 7% higher if suitable modification is done.

7) <u>Method using high temperature side glow peak</u> (Method due to Lushchik) :

By assuming that the area of the half peak towards the fall off is equal to the area of a traingle having the same hight and half width, Luschchik (17) showed that the activation energy for the first order kinetics is given by

$$E = \frac{k T_m^2}{(T_2 - T_m)}$$
 = ...(4.27)

under the same assumption, he obtained for the second order kinetics,

$$E = \frac{2K \text{ Tm}^2}{(T_2 - T_m)} \qquad \dots (4, 28)$$

for better accuracy, the above two equations have been empirically modified by Chen (9) by multiplying by 0.978 and 0.853 for the first and second order kinetics respectively.

In the above equations T_m is the glow peak temperature and T_2 is the temperature on high temp. side of the glow peak at which intensity falls to half of its peak value.

8) <u>Method using Low temperature of the Glow peak</u> (Method due to Halperin & Braner)

In this method, the use of symmetry of the glow peak about its maximum is considered to calculate the activation energy. Halperin and Braner (18,19) considered the luminescence emission as mainly due to two kinds of recombination processes.. In one process, the electron raised to an axcited state with the forbidden gap below the conduction band recombines with the hole by tunneling process and the other recombination takes place via conduction band. If it is assumed that the ratio $\frac{1}{5}$ of the initial concentration of trapped electrons to trapped holes is close to unity, then the thermal activation energy E can be calculated using the appropriate equations given below :

	Types of Process	Equation	Condition		
Tun	<u>meling</u> , = 1.	2			
a)	Recombination dominant	$E_1 = \frac{kT_m^2}{(T_2 - T_m)}$,Ug = e −1	(4. 29)	
ъ)	Retrapping dominent	$E_{2} = \frac{2kt_{m}^{2}}{(T_{2} - T_{1})}$	μ _g = .5	(4.30)	
<u>Via</u>	conduction band				

- a) First order dominent $E_{3} = \frac{1.72 \text{ KT}_{m}^{2}}{(T_{2} - T_{1})} (1-5.16) \mu_{g} e^{-1} (1+\frac{2}{\Delta}) --(4.31)$
- b) Second order dominant $E_4 = \frac{2KT_m^2}{(T_2 - T_1)}$ $(1 - \frac{6}{\Delta}) \mu_g \gg e^{-1}(1 + \frac{2}{\Delta})$

Where $\frac{1}{\Delta} = (\frac{KT_m}{L}) \ll 1$ is a correction factor and T_1 is the temperature on $\overline{18}w$ temperature side of glow peak at which intensity is 1/2 of its peak value. The factor $M_g = \frac{4}{W} = \frac{(T_2 - T_m)}{(T_2 - T_1)}$ is called the symmetry factor and is characteristics of the type of kinetics involved in the process. The value of μ_g equal to or less than e^{-1} ($1 + \frac{2}{\Delta}$) should be obtained for first order process while values greater than $e^{-1} \frac{i_S bi \gamma_0 / t (A | a \gamma)}{P}$. Thus the advantage of the method lies in the fact that the first half of the peak is sufficient for the evaluation of E and it also gives the direction for determing the kinetics involved in the process. But many times, the presence of weak shoulders at the high temp. side of the glow peak causes an apparent increases in the μ_g values which may wrongly indicate the process to be of the second order (20), when the ratio is greater than unity, the activation energy is given by,

$$E = \frac{KT_m^2}{(T_2 - T_m)} (1 + \frac{(T_2 - T_1)}{(T_m - T_1)}) \dots (4.33)$$

9) <u>Method using to full half width of the glow peak</u> (Method due to Chen)

The method suggested by then (9) to determine E follows from Randall and Wilkin's formula with the same assumption as made by Lushchik. For the first order kinetics E is given by

$$E = 2 KT_{m} \left(\frac{1.25 T_{m}}{T_{2} - T_{1}} - 1 \right) \dots (4.34)$$

and for second order kinetics

$$E = 2 \text{ KT}_{m} \left(\frac{1.756 \text{ T}_{m}}{\text{T}_{2} - \text{T}_{1}} \right) \qquad \dots (4.35)$$

Here the numerical constants are chosen empirically to have a better estimation of E and $\frac{E}{KT_m} >> 1$

Moreover then (21) showed that the symmetry factor, $\mu_g = 0.42$ is characteristics of the first order peaks while $\mu_g = 0.52$ of second order ones on correlating the symmetry factor μ_g and the order of kinetics, he gave the following equations to evaluate E for general order kinetics.

$$E_{T} = (1.51 + 3.0) (\mu_{g} - 0.42) KT_{m}^{2} \frac{1}{T_{m} - T_{1}} \dots (4.36)$$

$$- (1.5 + 4.2) (\mu_{g} - 0.42) \cdot 2 KT_{m}$$

$$E_{d} = (0-976 + 7.3) (\mu_{g} - 0.42) \cdot KT_{m}^{2} \frac{1}{T_{2} - T_{m}} \dots (4.37)$$

$$E_{w} = (2.52 + 10.2) (\mu_{g} - 0.42) \frac{KT_{m}^{2}}{T_{2} - T_{1}} - 2KT_{m}$$

$$\dots (4.38)$$

In addition to above, chen suggested corrections to the formulae suggested by the other workers which are as follows:

a) Chen's modification to method due to Grossweiner :

Chen modified the Grossweiner's relation (equation 4.26) empirically giving

$$E = \frac{C_1 k T_m T_1}{(T_m - T_1)} \dots (4.39)$$

Where $C_1 = 1.41$ for first order kinetics and $C_1 = 1.60$ for second order, which gives E values with better accuracy over a wide range of S values (10^6 to 10^{13} sec⁻¹).

b) Chen's modification to method due to Luschik

Chen suggested that if area under the glow curve is not exactly equal to the area of a traingle approximated, then Luschief is method needs correction. Accordingly he gave the correction and the formula are

$$E = \frac{C_6 k T_m^2}{T_2 - T_m} \qquad \dots (4.40)$$

With $C_6 = 0.976 \pm 0.004$ for first order kinetics and

$$E = \frac{C_{\gamma^2 \cdot k \cdot T_m^2}}{T_2 - T_m} \qquad \dots (4.41)$$

with $C_7 = 0.853 \pm 0.0012$ for second kinetics.

c) Chen's correction to method due to Halperin and Braner :

Applying some correction to method due to Halperin and Braner, Chen (9) suggested the equation for first order kinetics as

$$E_{H_1} = \frac{1.51 \text{ k } T_m^2}{(T_m - T_1)} - (1.58 \text{ x } 2 \text{ k } T_m) \dots (4.42)$$

and for second order kinetics at

$$E_{H_2} = \frac{1.81 \text{ K} \text{ T}_m^2}{(\text{T}_m - \text{T}_1)} - (2 \text{ K} \text{T}_m) \qquad \dots (4.42)$$

10) Inflection point Method :

The method proposed by Land (22) makes the use of inflection temperature, T_1 of the glow curve for evaluating E. The inflection temperature is given by setting $(d^2I / dT^2)=0$. for the intensity temperature relation. The equation obtained for E is

$$E = \frac{\frac{K T_m T_1}{T_1 - T_m}}{\frac{T_1 - T_m}{T_m}} \log \frac{A}{\frac{(T_1)^2}{T_m}} \dots (4.43)$$

Where A = 0.77 and 2.66 respectively for $T_1 < T_m$ and $T_1 > T_m$ for the first order kinetics, and A = 0.24 and 3.43 respectively for $T_1 < T_m$ and $T_1 > T_m$ for second order kinetics. Thus by measuring T_1 and T_m , E can be calculated.

11) Method due to Nambi, Bapat and Ganguly :

Thermal activation energy can be determined by the emperical formula developed by Nambi and coworkers (23) for $Caso_4$: RE phosphors. The relation between glow peak temperature T_m and activation energy E is given by

$$E = 3.12 \times 10^{-3} T_{m} - 0.23 \qquad \dots (4.44)$$

B) Methods independent of the Recombination kinetics :

1) Method due to Hoogenstraaten :

Using equation 4.19 Hoogenstraaten (24) has show that the peak temperature T_m is related to E by the equation :

$$\log e \left(\frac{Tm^2}{B}\right) = \frac{E}{KT_m} + \log \frac{E}{SK} \qquad \dots (4.45)$$

Thus the plot between log e (T_m^2 / β) versus $1/T_m$ is linear with a slope equal to E/K and making an intercept of log S K/E. Thus both E and S can be determined.

2) Initial Rise Method :

The method of initial rise, suggested by Garlick and Gibson (2) is based on the fact that for all types of the kinetics the intensity in the initial part of the glow curve can be expressed in the form

$$I = F. \exp(-E/kT)$$
(4.46)

T being a function of the number of completely filled traps and empty centres, which takes into account the transition probabilities involved. Assuming **P** to be constant in the initial part of the glow curve, the equation 4.42 takes the form.

 $\log_{\ell} (I) = -E/kT + constant \qquad \dots (4.47)$ A plot of log I against 1/T should give a straight line and the slope of which yields the value of E.

3) Numeracal kinetics Method :

This method of analysis (25) involves a numerical computation which proceeds in small arbitrary time steps. During each step the concentration of trapped charge, the carrier concentration of trapped charge, the carrier concentration, the radiative relaxation of excited centres etc. are adjusted in accordance with the physical process involved. When used to analyse the experimental data, some initial approximate values giving the best least square fit to the experimental data.

4.3.1: Methods for determination of escape frequency factor :

From the basic theory of luminescence, the expression for probability (p) of escape off of a trapped electron from a trap is given as

$P = S \exp (-E/kT).$

Where k is Boltzman constant, T is the absolute temperature and E is the activation energy. The pre-exponential factor 'S';called frequency factor because of its dimensions denotes the number of attempts per second made by a trapped electron to escape off. The value of S can be obtained from photoconductivity, phosphorescence decay, and thermoluminescence measurements. Several methods exists to determins S from TL studies and a brief survey is given below.

1) Method due to Randall and Wilkins :

Randall and Wilkins (1) for the first order kinetics, have given the solution of general equation $I = -\frac{dn}{dt}$, with a constant heating rate β as

I = Sn_o exp. (-E/kT) exp. (
$$-\frac{S}{B}$$
) $\int exp.(-E/kT')dT'$
T ...(4.48)

By equating the derivatives of this equation to zero, the condition for maximum of glow peak, one obtains

$$E / kT_m^2 = \frac{S}{B} exp. (-E/KT_m)$$
(4.49)

Where T_m is the temperature at the maximum of glow peak knowing T_m , β and E (determined by other methods) S can be readily evaluated.

2) Method due to Garlick and Gibson :

Following the second order kinetics, the solution of equation $I = -\frac{dn}{dt}$ given by Garlick and Gibson (2) with constant heating rate B is

$$I = S' n_0^2 \exp((-E/kT)).$$

$$\left[1 + (\frac{S' n_0}{B}) \int_{T_0}^{T} \exp((-E/kT')) dT\right]^{-2}$$
....(4.50)

differentiating the equation and equating the derivative to zero, the condition for maximum of the peak is

Assuming T_m to be the experimental peak temperature and with all other parameters in equation (4.51) are known, one can calculate the escape frequency factor $S = S' n_o$ for different values of E.

3) Isothermal Decay Method :

The method suggested by Gralick (14) for the first order kinetics points that in an isothermal decay, a plot of log I versust may be regardedas a sum of sharply defined linear regions of slope m given by the equation.

$$S = m \exp(E/kT)$$
 ...(4.52)

4) Method due to Curie :

As suggested by Curie (5), the glow peak temperature T_m and heating rate B are related to escape frequency factor by the equation of the type,

$$\frac{S}{B} = \frac{2}{\delta} \exp \frac{2 T_{m}}{\delta}$$
(4.53)

Where $\delta = T_2 - T_m$, is high temperature half width. Once the ratio of T_m / δ is known, the escape frequency factor S can be calculated.

5) Method due to Aramu and Maxia :

The method due to Aramu and Maxia (32) starts from the kinetic equation and allows to determine the frequency factor by the use of simplified formula.

$$S = \beta \exp_{\eta} \eta$$
 ...(4.54)

where β is heating rate and η is the intercept with the vertical axis of the plot of In I versus 1/T. The formula is applicable for the saturated glow peak and when the concentration of holes bound to luminescence centres is equal to the trapped electron concentration.

4.3. Determination of Size of trap :

The capture cross section (6) of each type of trapping centre can be evaluated from the knowledge of escape frequency factor.

Mott and Gurney (33) proposed the following equation, on the assumption that the density of free electrons (or holes in case of hole traps) is equal to the density of empty traps.

$$\frac{1/\tau}{6} = \frac{2 \pi m (kT)^2}{h^3} \sqrt{6 \pi} \exp(-E/kT) \dots (4.55)$$

on combining this equation with equation

 $P = \frac{1}{T} = S \exp(-E/KT)$ We have a numerical equation of the type

$$6 = \frac{S}{1.63 \times 10^{21} \times T^2} \qquad \dots (4.60)$$

Which in its simplest from be given as (3)

$$\frac{s}{6} = 1.5 \times 10^{26}$$
(4.56)

Knowing S, value of 6 can be estimated approximately.

4.4. RESULTS AND DISCUSSION :

Samples/prepared with Nd; Sm; Tb; Dy keeping fixed % of atom in the host material (Sample no. KD_2 , KD_3 , KD_4 , KD_5 resply). To see the starting contribution in the host material it is also prepared KD_1 (CaS undoped) with out adding impurities. Fig. 4.2. The glow curves of the prepared samples it that Dy, Sm, Tb and Nd are suitable (in descending order) as activator in the host material. fig. (4.2) exibits that there are few impurities introduced in the host material as starting contribution.

The samples KD (6), CaS : Tb:Nd, KD(7) CaS : Nd : Sm. KD(8) CaS : Tb:Sm and (KD, (9) CaS:Dy:Tb are prepared by keeping fixed % of atom for these samples to find best activator and after uverstation. second activator in the host material by visual inspection. It that is found RE_1 : RE_2 are Sm :Nd and Dy:Tb are suitable inthe host material.

4.5.1: <u>Results obtained when samples were excited by uV source</u> for 200 seconds :

a) <u>Glow Curve</u> :- Glow curves for various samples with different concentrations of (Sm, Nd) and (Dy, Tb) are shown in fig. (4.3 - 4.6) and fig. (4.7 - 4.10) respectively. The heating rate used for forecording all glow curves is 2° c/Sec. The measurements have been carried out in the temperature range of 27° c to 390° c. The temperature programmer fabricated in the department is used for linear heating. Fig. 4.1 shows temperature profile of the instrument.

As seen from the graphs fig. (4.3 - 4.5) a single broad peak at around 105°c is observed for all CaS :Sm :Nd phosphors, whereas two broad peaks are observed first broad peaks around 105°c and second broad peak around 190°c for all CaS :Dy :Nd phosphors, From the shape of glow curves it seems that the peak temperature slightly changes with concentration of activator Sm: Dy and second activator Nd : Tb in phosphors CaS :Sm :Nd and CaS :Dy :Tb respectively. The shift in peak temperature indicates that an apperent broad peak for all the phosphors, may be a composite peak having more than one peak and that these peaks are situated close to each other. Their resultant is indicated by a composite glow curve. In present study however the free peaks are not resolved using partial bleaching technique. Calculations of activation energies are done assuming the peak to be single.

It is observed that over all shape of the glow curve; is not significantly affected by concentration variation of activator and co-activator for all phosphors of composition CaS : Sm : Nd. The peak structure and peak temperature are however different for Cas:Dy:Tb . Only the peak intensity changes with concentration fig. (4.11 - 4.12) show the variation of peak intensity with concentration for phosphors CaS:Sm:Nd and CaS:Dy:Tb respectively. From these graphsit is seen that peak intensity increases and again decreases with concentration of activator and second activator. The variation of peak temperature and peak intensity is given in table 4.1 and 4.2. From graphs fig. (4.11 - 4.12) it is seen that the phosphors $CaS_{2}Sm_{.02\%}:Nd_{.02\%}and CaS_{2}Dy:_{.0075\%} Tb_{.02\%}$ gives maximum TL out put amongst choosen concentration by atom percentage. Most suitable combination of RE₁ and RE₂ in the host material is seems is to be Dy:Tb.

b) Activation Energy :

Activation energy E, of glow peak can be evaluated by several ways as described in section 4.2. In present study activation energies are calculated from the shape of the glow curve by using different formulae due to (i) Urbach (ii)Luschik (iii) Halperin and Branner (iv) Chen (v) Gross Weiner. Values of E calculated using different formulae are in agreement. Table (4.4 - 4.5).

An attempt is also made to find the activation energy by initial rise method for sample KD 31. Expical Arrhenius plots are shown in fig. (4.3.3). The activation energy calculated by this method is .46(eV) which is also in good agreement with the energies calculated by other methods.

c) Variation of activation energy with concentration :

Tables (4.4, 4.5) show that activation energy does not vary significantly with concentration. The effective trap levels are distributed over a range of 60 y to 67 evfor Cas :Sm:Nd phosphors and .36 ev to .67 for first peak and .44 to .78 for second peak for Cas:Dy:Tb phosphors. The observed variation in both cases is not systematic. This suggests that the addition of activator, second activator does not introduce any new traps but only modifies the relative importance of trap in Case of Cas:Sm:Nd, but are probably responsible for different traps in Cas:Dy:Tb for thermoluminescence. (22,23)

d) <u>Kinetics of Thermoluminescence</u> :

From the shape of the glow curve, nature of the kinetics involved in the TL process can be determined by knowing summetry factor $\mu_g = \frac{\delta}{M}$. The values of μ_g are listed in table (4.4, 4.5) for all samples. If $\mu_g = \frac{1}{2} \left(1 + \frac{2}{\Delta}\right)$ them the kinetics involved in TL process is second order. From table (4.4, 4.5) $\mu_g = \frac{1}{2} \left(\frac{2}{\Delta} + 1\right)$ for all the prepared samples which shows that kinetics involved for all in TL process may be second order.

Above statement is also supported by equation (4.8). A plot of $\frac{1}{\sqrt{1}}$ 'versus 't'in isothermal decay is a straight line, hence kinetics involved in TL process should be bimolecular. Plots of $\frac{1}{\sqrt{1}}$ Versus t fig, (4.14) for the samples KD 21 & KD 31 shows straight line for isothermal decay at temperature 100° cand 250° c resplyIt is explicit that TL process involved for all samples is bimolecular.

e) Escape frequency factor :

The escape frequency factor `S'is calculated by using equation (4.49). The value of S depends on E So there is large variation of S for small change of E. The S values are estimated by taking activation energies obtained from Urbach formula. Which are listed in table (4.8) for all samples.

f) Size of trap (6)

The capture cross section (6) of each type of trapping centre can be evaluted from the knowledge of escape frequency factor. The values of 6 are estimated by using equation (4.56) The values are listed in table (4.8). The size of the trap is of the order of 10^{-18} cm². Thus the trap in present investigation may be regarded as medium size trap.

g) Dose dependence :

The intensity of glow peak is found to be a function of irradiation dose. The plot of the glow peak intensity against duration of excitation, known as "Build-up curve " is shown in figure (4.15, 4.16) for the samples KD 21. The intensity of glow peak initially increases gradually and then saturates under uv excitation of 45 minutes.

4.5.2: A) Results obtained when excitation source used is Co (60) gamma source (dose of 4000 R/. minute for duration of 30 minutes).

The TL glow curve of the samples excited by gamma irradiation (4000 R/minute) are shown in fig.(4.17 - 4.19) The heating rate used is 2° c/sec. The measurement have been carried out in the temperature range of 27° c to 390° c. The glow curves are recorded 92 days after gamma irradiation. All the glow curves exhibites three peaksfirst around 155° c, second around 205° c and third peak around 260° c. The peak around 205° c is dominent for all prepared phosphors. Peak around 105° c observed in u.v. excited phosphors is missing which is probably due to (room temperature) decay at low temperature. The high temperature peak in gamma irradiated phosphors which is not observed in uv excited samples may be probably due to high energy irradiation creating desper traps which favour high temperature peaks. The observation how ever requires persual. General shape of the glow peak is same for all phosphors (Ca\$: Sm : Nd , Ca\$: Dy:Tb) . The peak temperature for first, second and third peak is also constant for all samples. The peak intensity changes with activator concentration However the change is not systematic (table 4.3) it is difficult to arrive at a systematic conclusion regarding concentration variation and TL out put.

It was confirmed by following procedure that gamma irradiation do**gg** not cause radiation damage in phosphors. After recording TL glow curve of gamma irradiated sample the same sample was u.v. excited and its TL was recorded. The shape of glow curve, peak temperature and peak intensity remains unaffected. B) Activation energy :

In present study activation energies for peaks ($155^{\circ}c$, $205^{\circ}c$ and $260^{\circ}c$) are calculated by Urbach formula, table(4.7) for all prepared phosphors. From table (4.7) it is observed that activation energies for a peak ($155^{\circ}c$ or $205^{\circ}c$ or $260^{\circ}c$) almost remain constant for all samples. These activation energies are higher than those obtained for u.v. excited sample by using same formula table (4.4, 4.5). This that there are deeper traps also introduced in the samples.

C) <u>Kinetics of the luminescence</u> :

The kinetics involved in TL is determined by calculating the value of symmetry factor (Mg). It is observed that Mg is grater than 1/e (table 4.7). Which Markets that order of kinetics may be second order.

d) Escape frequency factor :

The escape frequency factor '\$ 'is evaluated by using equation (4.49). The values of S calculated are listed in table (4.7) and are in the range of 10^9 sec^{-1} for variation in activator concentration.

e) Size of trap :

The size of trap is calculated by using equation (4.56). The values are listed in table (4.7). The size of the trap is of the order of 10^{-18} cm². The traps may be regarded as medium size trap.

4.6 SUMMERY :-

The important features of this chapter can be summarised as follows :

1) Shape of the glow curves mainly depends on the concentration of activator RE_1 and second activator RE_2 . The relative peak intensities are significantly influenced by RE_1 and RE_2 .

 Addition of activators do not give rise to new glow peak in the temperature range studied.

3) The trap depths of effective levels are insensitive to the concentration of activators RE_1 and RE_2 .

4) The probable kinetics involved in TL process is of second order (bimolecular).

5) The glow peak intensity is a function of excitation time.

REFERENCE

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1)	Randall, J.T. and Wilkins, M.H.F., Proc. Roy.Soc.(London),
	A 184, 366 1945.
2)	Garlik, G.F.J.and Gibson, A.F., proc. Roy.Soc. (Londan)
	A 60, 574 ,1948, .
3)	Shalgaonkar, C.S. and Narlikar, A.V. , J.Material Sci. 7, 1465 (1972).
4)	Urbach, F., Corner Symposium (Wiley, New York), 115, 1946 .
5)	Curie, D. "Luminescence in Crystals " (Methuen)London, 162, (1963).
6)	Pawar S.H., Lawangar, R.D., Shalgaonkar C.S. and Narlikar, A.V. Phil.Mag. 24, 729 (1971).
7)	Sharma, and Singh, A. Indian J. Pre Appl. Phys. 7,130 1969.
8)	Agnihotri, V.B. and Ranade, J.D., Indian J.Pure Appl.Phys. 6,70 (1968).
9)	Chen, R.J., Appl. Phys. 40, 570 1969.
10)	Booth, A.H., Cand, J,Chem. 32, 214 1954.
11)	Bohun, A. Czeeh, J.Phys. 4,19 1954
12)	Wrezesinka, A., Acta. Phys. Polonica, 15, 151 1956.
13)	Schon, M. Tech. Wiss Abh. Osram. Ges.,7,175 1968 .
14)	Garlick,G.F.J. " Luminescent Materials " (OxFord Univ.Press, N.Y.)(1949).
15)	Grossweiner, L.T., J.Appl.Phys., 24, 1306 1953.
16)	Dussel, G.A. and Bube, R.H., Phys.Rev., 1955,764 1967.
17)	Lushchik,G.B., Soviet Phys. Jetp, 3, 390 1956.
18)	Halperin, A. and Branner, A.A. Phys. kev., 117,408 1960.
19)	Halperin, A. and Branner, A.A. Ben.zui, A,and Kristipoller, N., Phys. Rev. 117, 416 1960.

.

.

- 20) Lawangar, R.D., Shalgaonkar, C.S., Pawar, S.H. and Narlikar, A.V., Solid states Comm. 10, 1241 1972.
- 21) Chen, R.J. Elec. Chem.Soc., 116, 1254 1969.
- 22) Land, P.L., J.Phys.Chem. Solids, 30,1681 1959.
- 23) Nambi, K.S.V., Bapat, V.W. and Ganguly, A.K., J.Phys. C 7, 1103 (1974).
- 24) Hoogenstrasten, W., Philips Res. Reports, 13, 515, 1958.
- 25) Muntoni, C., Rucci, A. and Serpi A., Ricarca, Sci.<u>38</u>, 762, (1968).
- 26) Sunta Et.al. Kinetics of thermoluminescence glow peaks, Bulletin of rediation protection, Vol. 2, No.4 Oct.Dec. 1979.
- 27) Braunlich, P., Thermoluminescence and thermally stimulated current Tools for the determination of trapping parameters in thermoluminescence of geological material Ed. by D.J.DcDougall (Academic Press, London and New York, (1968) p.61.
- 28) Kelly, P. and Braunlich, P. Phenomenological theory of Thermoluminescence; Phys. Rev. B1 (1970). 1587.
- 29) Shenkar, D. and Chen, R; Numerical Solution of the glow curves differential equations; J. Computational Phys. 10, (1972), 272.
- 30) Murti, Y.V.G.S., and Murthy K.R.N. and Rr_esastry; Thermoluminescence of Cu activated NaCl crystals; J.Phy. C.(Sol. St.Phy.) 5 (1972) f 2827.
- 31) Braunlich, P.Comments on the initial rise method for determining trap depths, J.Appl. Phys. 38, (1967) 2516.
- 32) Aramu, F. and Maxia, V., J.Luminescence, 10,77 1975
- 33) Mott, N.F., and Gurney, R.N. Electronics processes in Ionic crystals (OxFord, Clarendon, 1948) p.108.

- 34) Jain, S.C. and Bhawalkar, D.R., Indian J.Pure Appl. Phys. 613,74 (1975).
- 35) Sinha, O.P. and Sivaraman, S., Indian J.pure Appl. Phys. 10, 134 (1972).
- 36) Patil, M.G. Ph.D. thesis, Shivaji University, Kolhapur (1981).
- 37) Bettinalli, C., Ferraresso, G. and Muntoni, J.W., J.Chem. Phys. 50, 3957 (1969).
- 38) Lax, M. Phys., Rev. 119, 1502 (1960).
- 39) Nambi, K.S.V. ' Thermoluminescence, its understanding and Applications', Brazil (1977).
- 40) Beeven H.J., J. Phys. Chem. Sol., 36 (949) 1915.
- 41) May C.E. and partridge J., J.Chem. page 40, 1964.

TABLE NO.4.1

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ek PEAK TEMPERATURE نر AND PEAK TL INTENSITY (ARBUNIT.)

FOR THE PHOSPHORS Cas:Sm:Nd EXCITED UNDER ULTRAVIOLET

SOURCE :

% vari	ation of S	n. (% Variation of Nd			
Sample No.	Peak Temp.	Peak TL intensity	Sample No.	Peak Temp.	Peak TL Intensity	
KD 13	393	470	KD 2 0	383	1400	
KD 14	383	1700	KD21	383	2400	
KD 15	383	950	KD22	393	2300	
KD 16	365	1600	KD23	383	⁷ 800	
KD 17	393	650	KD24	383	1850	
KD 18	387	620	KD 2 5	373	1800	
KD 19	393	230	KD 26	351	550	
	€ • •	1 8 8 8	KD 2 7	357	175	
	1		KD 28	323	90	

TABLE NO. 4.2

PEAK TEMPERATURE ^OK AND PEAK INTENSITY (IN Arb. UNITS) FOR THE PHOSPHORS Cas:Dy:Tb EXCITED UNDER ULTRA VIOLET SOURCE :

• • • • • • • • • • • • • • • • • • •									
Sample No.	% Variation of Dy.								
NO.	Peak	I	Peak II						
*	Peak Temperature Ok	Peak TL intensity	Peak Temperature °k	Peak TL intensity					
KD 2 9	337	560	453	760					
KD 30	341	800	435	670					
KD 31	373	1100	423	1400					
KD 32	333	500	393	440					
KD 33	343	255	423	165					
KQ 34	343	150	443	115 80					
KD 35	335	220	443						
KD 36	343	85	435	67					
KD 37	327	54	443	28					
KD38	337	200	423	70					
KD 39	343	130		-					
KD 40	339	65	423	25					
1									
Sample No.		% Variation	of Nd						
	Pea	<u>k I</u>	Peak	II					
· • • • • • • • • • • • • • • • • • • •	Peak temp.	Peak TL intensity	Peak temp.	Peak TL intensity					
KD 41	343	323	435	90					
KD 42	343	700	435	510					
KD 43	343	360	435	135					
KD 44	343	415	435	150					
 				ین من من من من من من بن بن بن من					

TABLE NO. 4.3

PEAK TEMPERATURE IN ^OK AND PEAK INTENSITY IN Arb. UNIT FOR THE PHOSPHERS UNDER y - IRRADIATION SOURCE

Sample No.	Cas:Sm:Nd % variation of Sm							
	Pet	ak I	Pe	ak II	Peak III			
****	Peak 1 Temp.	Peak ⁱ L intensity		Peak TL	Peak Temp.	• Peak TL intensity		
KD13	413	1 31	 -	l	523	500		
KD14	413	76	453	8500	543	990		
KD15	-	· -	-	I —				
KD16			, -	· _	-	· –		
KD17	I 433	1 78	453	1200	533	50		
KD18	413	25	453	180	523	¹ 45		
KD19	-	-	-	1 -	543	60		
	L	1	variatic	n of Na		L		
	F =========	r				r		
Kd20	I 413	130	453	120	533	115		
KD21	353	250	433	140	-	· _		
KD 2 2	413	150	453	920	543	100		
KD 2 3	413	120	453	120	513	270		
KD24	I 413	100	453	400	-	t		
KD25	413	120	473	.320	543	1 82		
KD 26	413	155	453	700	543	300		
KD 2 7	• -		453	1100	-			
KD28	1 (I <u>-</u> I	453	1100	553	150		
	L!	L		·		L		
		as:Dy:Nd	%variat	ion of Dy				
KD 32		- 1	453	300	563	100		
KD 33	۱ <u> </u>	I	473	140	_ !	• -		
KD 34	! - (!	453	400	563	32		
KD 35	. –	· - '	473	345 1	563	24		
KD 36	413	20	473	1100	553	70		
KD 37	1 <u> </u>	- 1	453	800	553	120		
KD 38	413	60	453	8000	563	85		
KD 39	413	48	-	I I	543	18		
KD 40	413	20	453	30	543	22		
	ا)		

TABLE NO. 4.4

ACTIVATION ENERGY SYMMETRY FACTOR FOR ULTRAVIOLET EXCITED

Cas.Sm:Nd, samples using different formulae in eV

EU : Energy due to Urbach.

EL : Energy due to Lushchik.

E . Energy due to Luschik and Chen's modification.

Ec : Energy due to Chen.

EHBC: Energy due to Halperin and Braner with Chen's modification.

ECG : Energy due to Gross weiner with Chen's modification.

- Sample No.	na	Ē	EL	ELC	E _{HBc}	Ēcg	Ec
KD13	.78	.789	.48	.40	.46	.41	.78
KD14	•45	.76	.70	* 59	.44	.41	1.10
KD15	.62	.73	.49	.41	.68	.63	. 81
KD16	.40	.76	.50	.42	.50	.47	1.70
KD 17	.43	.78	. 84	.71	.34	.38	1.73
KD18	•23	.77	1.12	.95	.83	1.02	1.75
KD19	,38	. 78	.95	.81	1.029	.80	1.4
KD20	.43	.766	.66	•56	.39	.36	.8
KD21	.42	.766	.90	.76	.538	.50	1.10
KD 2 2	.42	.78	.88	.75	.53	.50	1.1
KD 2 3	.59	.76	.60	.51	.48	.34	.99
KD24	.43	.76	.63	.53	.37	.35	.78
KD25	.41	.74	.92	.78	•54	.50	1.1
KD 26	.52	.74	.53	.45	.47	.45	.87
KD27	.58	.71	.64	.54	.76	.71	1.07
KD28	.64	.64	.54	.44	.67	.64	.73

TABLE No.4.5

ACTIVATION ENERGY (Symmetry factor) FOR ULTRAVIOLET EXCITED. Cas:Dy:Tb SAMPLES FOR FIRST PEAK USING DIFFERENT FORMULAE IN eV':

Sample No.	'ng	E _U	EL	^E Lc	E _{HBC}	^E CG	^E c
KD29	.79	.64	.42	.36	1.30	1.30	.68
КО 30	.80	.67	.30	.26	1.00	1.00	.47
KD 31	.42	.68	.39	.39	.35	.37	.43
KD 32	.84	.74	.31	.27	1.06	1.55	.50
KD 3 3	.64	.66	.40	.34	•59	.55	•65
KD 34	.65	.68	.44	.37	.70	.66	.71
КD 35	.77	.68	.40	.34	.73	.70	.65
KD 36	.59	.67	.63	.54	.77	.72	1.05
KD 37	.92	.68	.38	. 32	-	-	.61
KD 38	.69	.65	.54	.46	1.0	.97	. 89
KD 39	.48	.67	.39	.38	.45	.46	.91
KD 40	.70	.68	.41	.35	.84	.78	.66
KD 41	.71	.726	.45	.38	.96	.9	.73
KD 42	.51	.76	.90	.76	.81	.76	.67
KD 4 3	•91	.69	.32	.27	. 6	.9	.67
KD 44	.62	.73	.58	.49	.81	.76	.95
			i } !	i 1 1)) !	

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TABLE No.4.6

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ACTIVATION ENERGY (Symmetry factor) ULIRAVIOLET EXCITED SAMPLE Cas:Dy:Tb FOR SECOND PEAK IN eV

Sample No.	'ng	EU	E _L	^E Lc	^Е нвс	E _{CG}	Ec
KD29	.50	.90	。61	. 52	.49	.46	.99
KD 30	.43	.87	.28	.28	.30	.34	.62
KD 31	.58	. 84	.48	. 41	.53	.44	.77
KD 32	.59	.70	. 41	.36	.48	.45	.66
KD 33	.64	.84	.52	.45	.86	.80	.84
KD 3 4	.43	.88	.34	.36	.37	.37	.76
KD 35	.44	.88	.34	.36	.36	.38	.76
KD 36	.49	.87	.27	.27	.30	.34	.61
KD 37	.55	.87	.44	.37	.49	.45	.70
KD 38	.56	.87	.46	.39	.48	.45	.74
KD 39	-	-	-	-			, , , , ,
KD 40	.56	.84	.44	.39	.48	.44	.75
KD 41	.45	.866	.78	.66	.64	.59	1.30
KD 42	.2	.866	L	-		-	1 5 6 -
					; ; ,		

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TABLE : 4.7 :- ACTIVATION ENERGY, FREQUENCY FACTOR (FROM EU) AND SIZE OF

TRAP FOR THE SAMPLES IRRADIATED UNDER Y - SOURCE

PREQUENCY PACTOR 1 <u>S --- ACTIVATION ENERGY (eV), S -</u> Sec⁻¹ - SIZE OF TRAP (Cm²) ;

Sample		First peak	• • • • • • • • • • • • • •		Second peak	0 6 7 7 7 7 8 8 8 8 8 8 8 8 8 8 8 8 8 8 8		Third peak	×.
NO.		S		ш	S		÷.	S	Ś
	2		4	ŝ	9	7	00	6	10
KD 13	.84	2.1×10 ⁹	1.3x10 ⁻¹⁷	8	i	I	1.04	эх10 ⁸	5.7×10 ⁻¹⁸
KD 14	. 82	1.1×10 ⁹	7.0x10 ⁻¹⁸	• 94	2.9×10 ⁹	1.8×10 ⁻¹⁷	1.08	8.8x10 ⁸	5.6x10- ¹⁸
KD 15	ł	1	1	1	t	1	1	I	ı
KD 16	1	ł	1	1	1	1	1	I	ſ
KD 17	. 86	1.06×10 ⁹	6.7x10 ⁻¹⁸	\$6.	2.9×10 ⁹	1.8×10 ⁻¹⁷	1.04	8.9×10 ⁸	8.5×10 ⁻¹⁸
KD 18	.84	2.1×10 ⁹	1.3x10 ⁻¹⁷	• 94	2.9×10 ⁹	1.8×10 ⁻¹⁷	1.04	8.9x10 ⁸	8.5×10 ⁻¹⁸
1 9				.87	1.4×10 ⁹	8.9×10 ⁻¹⁷	1.08	8.8x10 ⁸	5.6x10 ⁻¹⁸
XO 20	.84	2.1×10 ⁹	1.3×10 ⁻¹⁷	94	2.9×10 ⁹	8.9×10 ⁻¹⁷			
KO 21	. 72	2.5x10 ³	1.6×10^{-17}	. 85	1.4×10 ³	8.9×10 ⁻¹⁷	1.066	8.9×10 ⁸	8.6x10 ⁻¹⁸
KO 22	.84	2.1×10 ⁹	1.3×10 ⁻¹⁷	4 6 .	2.9x10 ⁹	1.8×10 ⁻¹⁷	1.08	8.8×10 ⁸	5.6x10 ⁻¹⁸
K 23	- 86	1.06×10 ³	6.7x10 ⁻¹⁸	•	1	ı	1.02	9.2×10 ⁸	5.8×10 ⁻¹⁸
KO 24	. 84	2.1×10 ⁹	1.3×10 ⁻¹⁷	46.	2.9x10 ⁹	1.8×10 ⁻¹⁷	1	1	1
KD 25	. 86	1.06×10 ⁹	1.3×10 ⁻¹⁷	- 96	1.6×10 ⁹	1.02×10 ¹⁷	1.08	8.8×10 ⁸	5.6x10 ⁻¹⁸
	1 4 1 1 1		& C 9 # 8 # 7 # 7 # 7 # 7 #	 			 	contdnext	xt page

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	8			5	0		α	0	
KD. ⁷ 26	9 4	2.1×10 ⁹	1.3x10 ⁻¹⁷	.94	2.9x10 ⁹	i.9x10 ⁻¹⁷	1	9.8x10 ⁸	5.6x10 ⁻¹⁸
KD_27	1	I	1	4 6 .	2.9x10 ⁹	1.9×10 ⁻¹⁷	1	t	1
10 28	I	J	1	9 6	2.9x10 ⁹	1.9×10 ⁻¹⁷	ר. ה	8.5×10 ⁸	5.5x10 ⁻¹⁸
त ट्र	1	1	1	46 .	2.9×10 ⁹	1.8×10 ⁻¹⁷	1.12	8.5x10 ⁸	5.4x10 ⁻¹⁸
93 93	ł	1	ł	96.	1.5×10 ⁹	1.02×10 ⁻¹⁷	1	1	1
6 34	1	1	1	94	2.9×10 ⁹	1.8x10 ⁻¹⁷	1.12	8.5x10 ⁸	5.4x10 ⁻¹⁸
Q 32	1		1	.96	1.5×10 ⁹	1.02×10 ⁻¹⁷	1.12	8.5x10 ⁸	5.4x10 ⁻¹⁸
80 36	• 34	2.1×10 ⁹	1.3×10 ⁻¹⁷	96•	1.5×10 ⁹	1.02×10 ⁻¹⁷		8.5x10 ⁸	5.5×10 ⁻¹⁸
KD 37	1		1	46.	2.9×10 ⁹	1.8±10 ⁻¹⁷		8.5x10 ⁹	5.5x10 ⁻¹⁸
19 19 19	•84	2.1×10 ⁹	1.3×10 ⁻¹⁷	46.	2.9x10 ⁹	1.8×10 ⁻¹⁷	1.12	8.5x10 ⁸	5.4×10 ⁻¹⁸
65 Q	.84	2.1×10 ⁹	1.3x10 ⁻¹⁷	1	1	1	1.08	a.sx10 ³	5.5x10 ⁻¹⁸
KD 40	. 34	2.1×10 ⁹	1.3×10 ⁻¹⁷	\$6 •	2.9x10 ⁹	1.9x10 ⁻¹⁷	1.08	8.9x10 ⁸	5.5x10 ⁻¹⁸
	1						·		

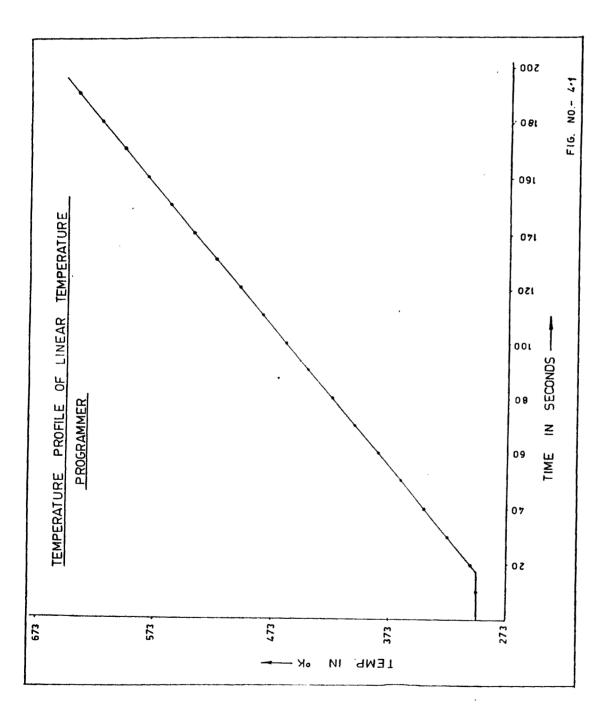
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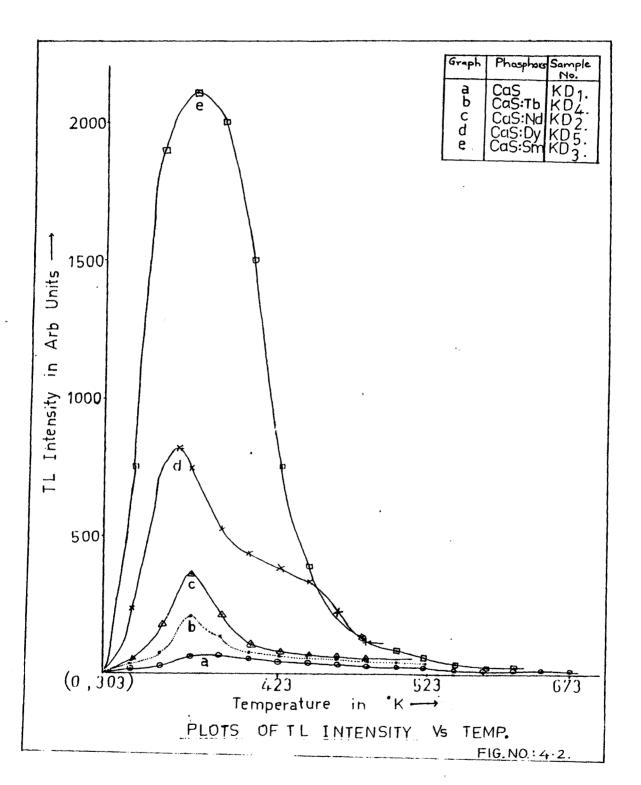
TABLE No.4.8 : ESCAPE FREQUENCY FACTOR (Using Eq.) AND SIZE OF TRAP EXCITED SAMPLES UNDER

OF TRAP	FXCITED SAMPL	ES UNDER UV :		
Samalo	Peak	I	Pea	ak II
Sample	Sec ¹	6 (Cm) ²	Sec ⁻¹	β (Cm) ²
No.	Sec-	0 (Cm)	Sec) 8 (Cm)
KD13	1.38x10 ^{9.}	8x10 ⁻¹⁸		
KD14	1.42x10 ⁹	9.1x10 ⁻¹⁸		1
KD15	1.42×10^9	9.1×10^{-18}	1	Î E
KD16	1.48x10 ⁹	9.1×10^{-18}		
KD17	1.38×10^{9}	9.48x10 ⁻¹⁸	\$ \$	
. KD18	1.42×10^9	9.1×10^{-18}	1 7 7	
KD19	1.42×10^9	8.84×10^{-18}	1 2	
KD 2 0	1.38×10^9	9.1×10^{-18}	1	
KD21	1.42×10^9	9.1x10 ⁻¹⁸		
KD 2 2	1.38×10^9	8.84x10 ⁻¹⁸	1	
KD23	1.42×10^9	9.1x10 ⁻¹⁸		
KE124	1.42×10^9	9.1x10 ⁻¹⁸	1	
KD25	1.28x10 ⁹	8.2×10^{-18}		
KD26	2.35x10 ⁹	1.5×10^{-17}		
KD27	1,52x10 ⁹	9.74×10^{-18}		
KD28	1.68x10 ⁹	1.07×10^{-17}		
KD29	1.46x10 ⁹	9.73×10^{-18}	1.28x10 ⁹	8.53x10 ⁻¹⁸
KD 30	1.6x10 ⁹	1.06×10^{-17}	1.25x10 ⁹	8.33x10 ⁻¹⁸
KD 31	1.06×10^{9}	1.06×10^{-17}	1.2x10 ⁹	8x10 ⁻¹⁸
KD 32	1.63x10 ⁹	1.07×10^{-17}	1.38x10 ⁹	9.2x10 ⁻¹⁸
KD 3 3	1.59x10 ⁹	1.06×10^{-17}	1.2×10^9	8×10 ⁻¹⁸
KD 34	1.52×10^9	1.06×10^{-17}	1.23×10^9	8.2x10 ⁻¹⁸
KD 35	1.62×10^9	1.08x10 ⁻¹⁷	1.23x10 ⁹	8.2×10^{-18}
KD 36	1.59x10 ⁹	1.06×10^{-17}	1.25x10 ⁹	8.33x10 ¹⁸
KD 37	1.66x10 ⁹	1.1×10^{-17}	1.23×10 ⁹	8.2x10 ⁻¹⁸
KD 38	1.46x10 ⁹	9.7x10 ⁻¹⁸	4.2×10 ⁹	8×10 ⁻¹⁸
KD 39	1.59x10 ⁹	1.06×10^{-17}	-	-
КО 40	1.49x10 ⁹	9.93x10 ⁻¹⁸	5.08x10 ¹⁰	8x10 ⁻¹⁸
KD41	1.5×10^9	4.7×15-18	-	-
KD 42	1.42x10 ⁹	9.1 ×10-18	-	-
KD 43	5.9x10 ⁸	3.9 X1018	- 1	-
KD 44	1.48×10 ⁹	9.1 × 10-18		-
	!	• • • • • • • • • • • • • • • • • • •	 	

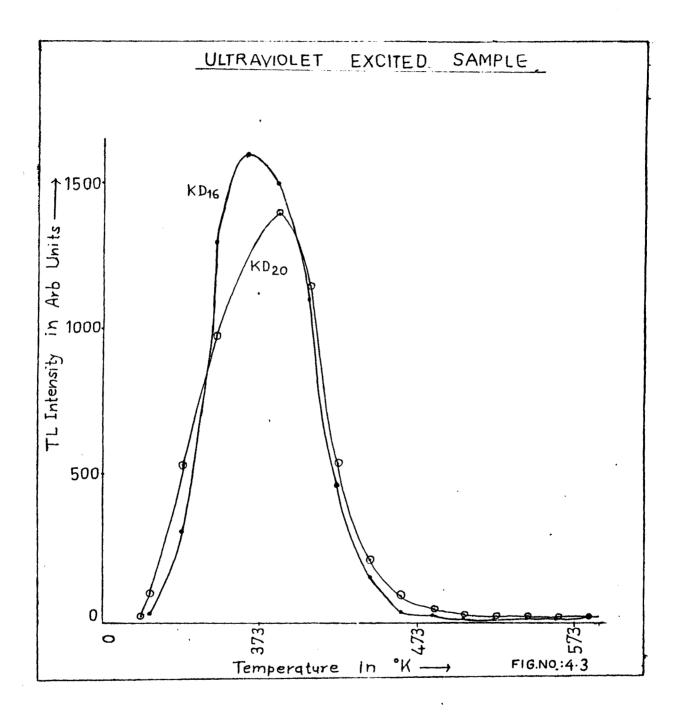
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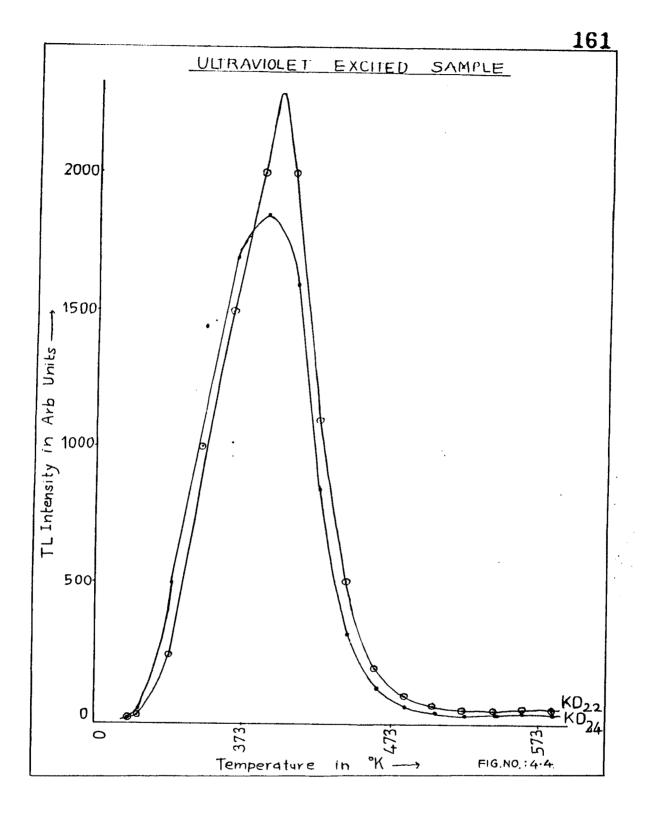
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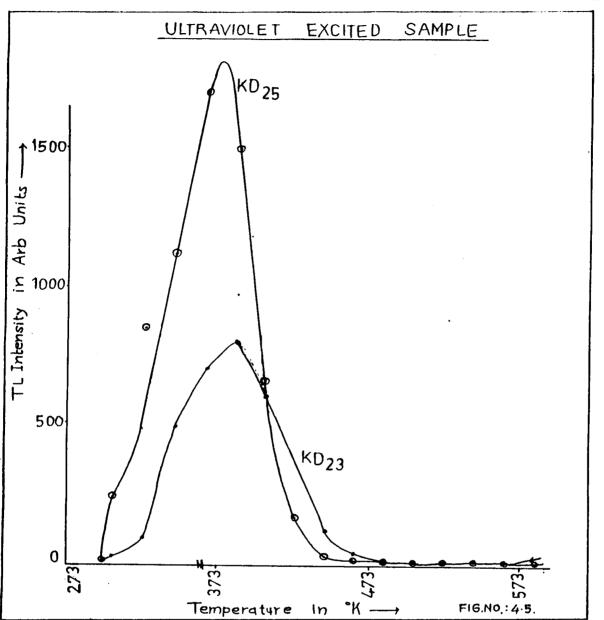


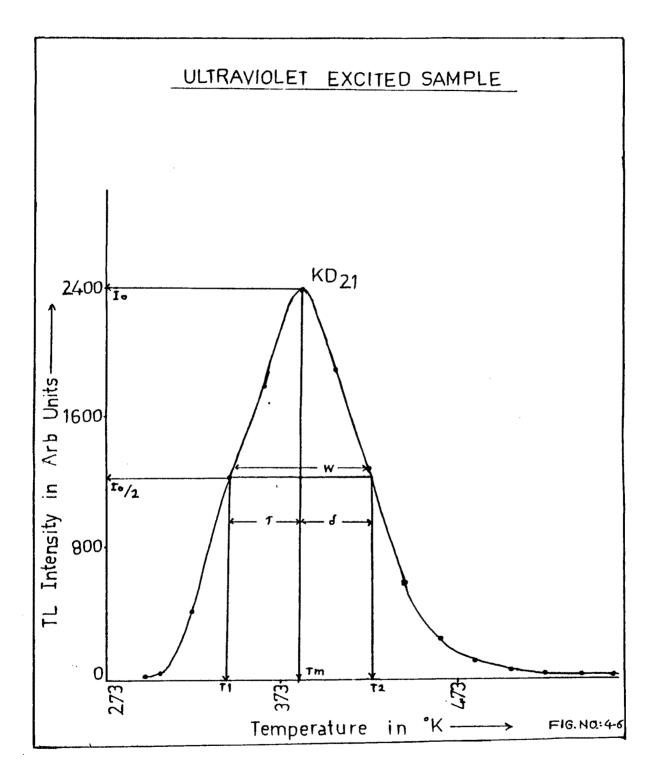


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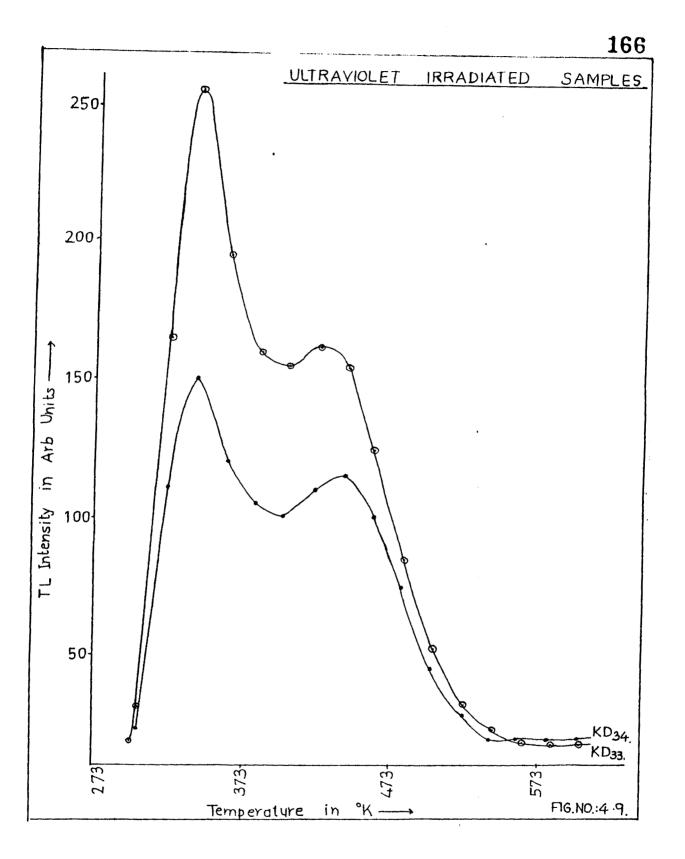


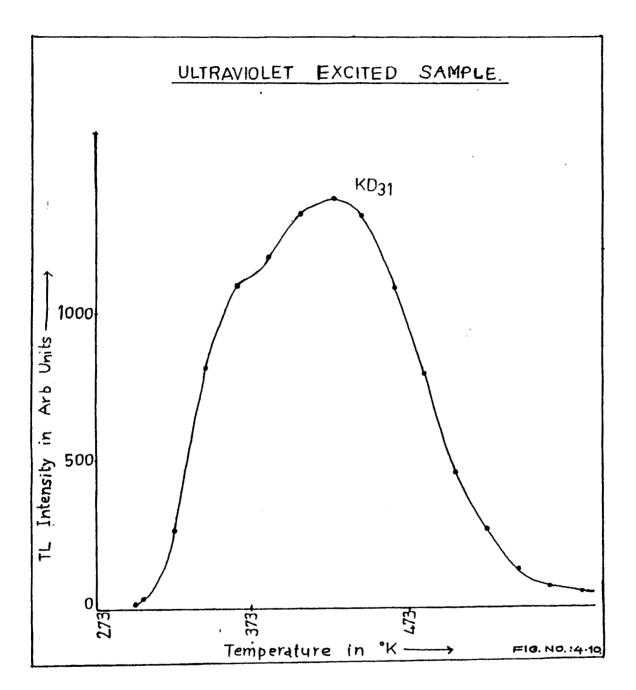




ULTRAVIOLET IRRADIATED SAMPLES 800 720 640 u 480 uits u 480 uits u 400 u 560 TL Intensity 770 770 160 80 KD29 KD30. Ò õ 373-573-273 473-Temperature FIG. NO.: 4 7. °K in

IRRADIATED SAMPLE ULTRAVIOLET 90 TL Intensity in Arb Units -60 . 30 KD36. Ø 573-373-473 273 FIG. NO. 4.8. Temperature °K in





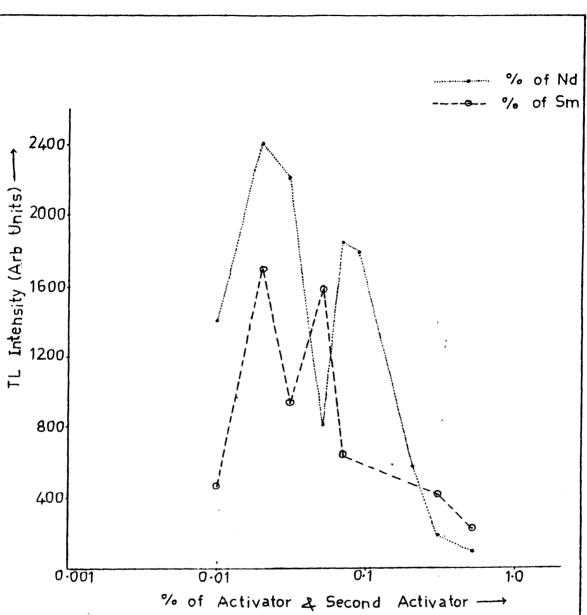
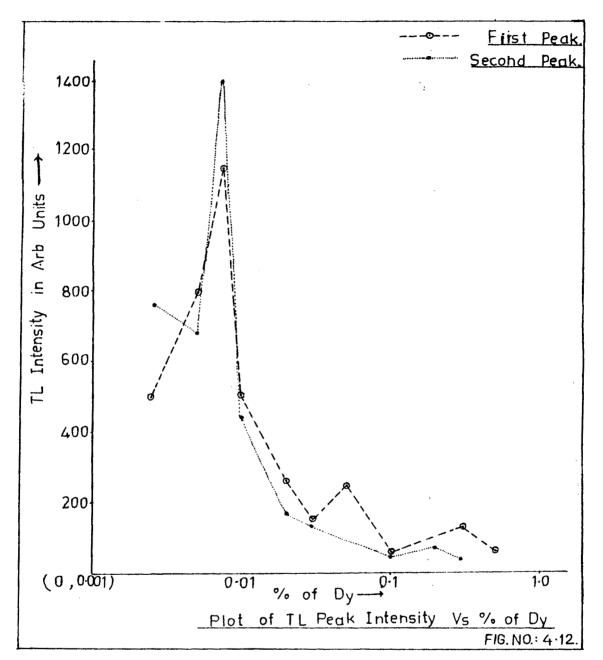
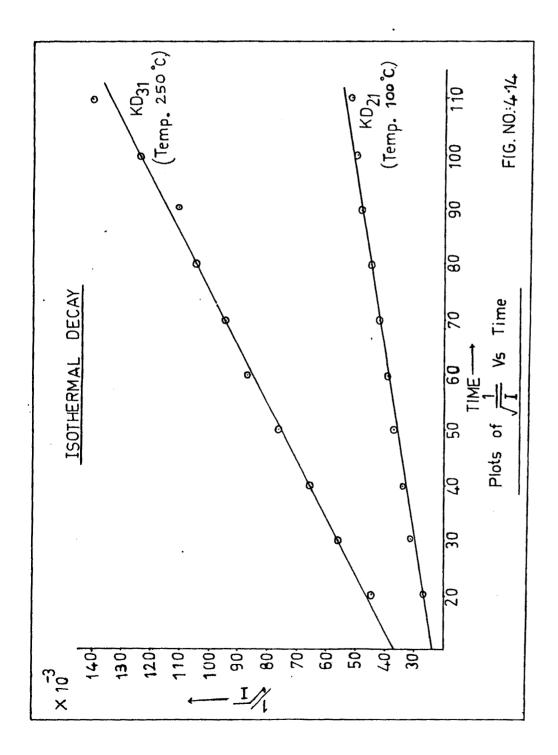


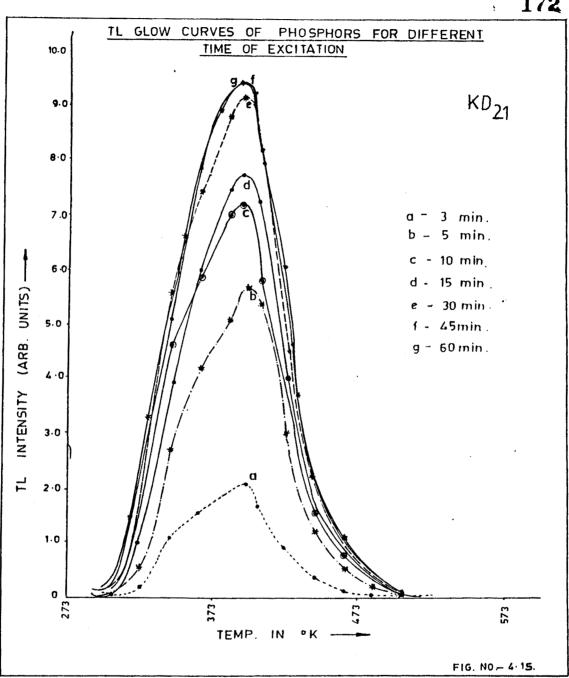
FIG. NO.: 4-11



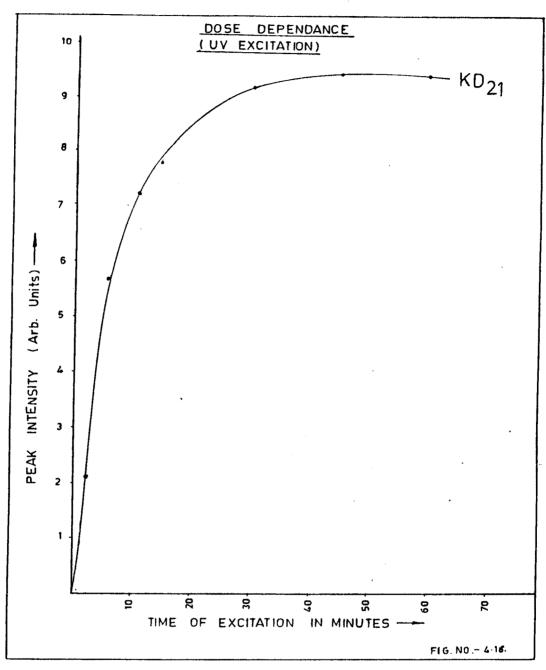
AREHENIUS PLOTS (Initial Rise Method) 1.5 tog I → 0 1.0o 33 1/_T -32 34_4 × 10 Plot of I Vs $\frac{1}{T}$ for Sample KD₃₁ FIG. NO: 4.13.



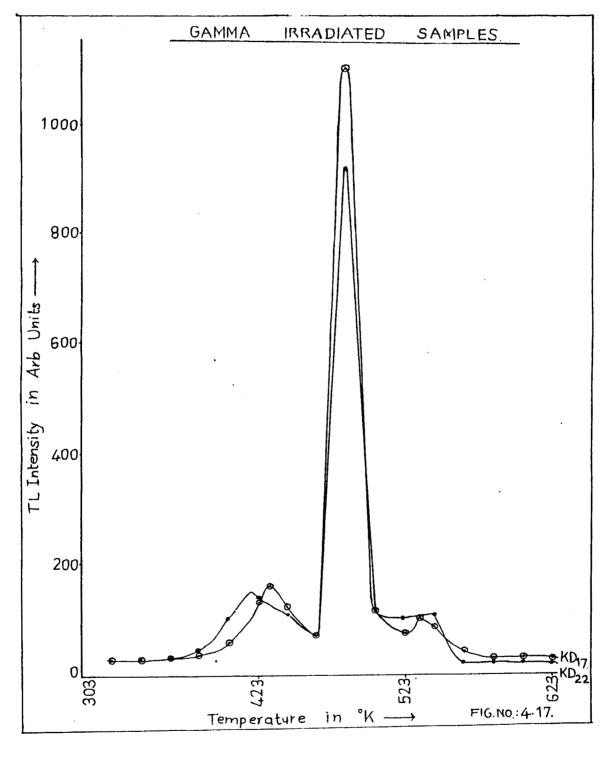








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